




<p align="center">Searched</p> 	<p>Application/Control No.</p> <p>10801871</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>CHANDHOK ET AL.</p>
	<p>Examiner</p> <p>Dildine, R. Stephen</p>	<p>Art Unit</p> <p>2133</p>

Class	SubClass	Date	Examiner
714	748-749	06/16/2006	RSD

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Search Notes 	Application/Control No. 10801871	Applicant(s)/Patent Under Reexamination CHANDHOK ET AL.
	Examiner Dildine, R. Stephen	Art Unit 2133

Notes	Date	Examiner
US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB (test search, see Search History printout)	06/16/2006	RSD
IEEEExplore	06/16/2006	RSD
G08C 25/02 and H04L 1/18 (foreign documents only, see Search History printout)	06/16/2006	RSD
Inventors' name Search	06/15/2006	RSD
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<i>Interference Searched</i> 	Application/Control No. 10801871	Applicant(s)/Patent Under Reexamination CHANDHOK ET AL.
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Text search (see Search History printout)		06/16/2006	RSD

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